

DK-105787-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark / Brand (if any)

Intel® NUC (Mini PC)

INTEL CORPORATION

2200 Mission College Blvd Santa Clara, CA 95054 USA

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2200 Mission College Blvd Santa Clara, CA 95054 USA

MAINTEK COMPUTER (SUZHOU) CO LTD 233 JIN FENG RD NEW DISTRICT SUZHOU JIANGSU 215011 CHINA

Additional Information on page 2

19Vdc, 4.74A or 19Vdc, 6.32A

INTEL



Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

NUC11TNH, NUC11TNK, xNUC11xTNHx, xNUC11xTNKx (where x can be a combination of alphanumeric characters or blank)

Additionally evaluated to EN 62368-1:2014/A11:2017; National Differences specified in the CB Test Report.

Additional Information on page 2

IEC 62368-1:2014

ASL20080637 issued on 2020-11-12

This CB Test Certificate is issued by the National Certification Body



Date: 2020-11-17

UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK

UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

Signature:

For full legal entity names see www.ul.com/ncbnames

Jan-Erik Storgaard